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### **Chapter 67 scanning probe microscopy and**

G. Binnig, Ultramicroscopy 42 (1992) 7. [9] H.K. Wickramasinghe, Scanned Probe Microscopy, AIP Conference AIP Conference Proceedings (1992), p. 241

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"Printing arrays of nano-holes with EUV Compact lasers," 4th Latin-American Symposium on Scanning Probe Microscopy AIP Conference Proceedings, 808, 241,

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